

<b>Notice of References Cited</b>	Application/Control No. 10/785,002		Applicant(s)/Patent Under Reexamination FUJIBAYASHI, AKIRA	
	Examiner Niketa I. Patel		Art Unit 2181	Page 1 of 1

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*	B	US-2002/0083281	06-2002	Carteau, Daniel	711/161
*	C	US-2004/0080558	04-2004	Blumenau et al.	347/019
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